

REMARKS:

The above-referenced application is amended to revise the drawings to be consistent and to better describe the invention without introducing new matter.

Entry is in order.

To the extent necessary, a petition for an extension of time under 37 C.F.R. 1.136 is hereby made. Please charge any shortage in fees due in connection with the filing of this paper, including extension of time fees, to Deposit Account 07-1337 and please credit any excess fees to such deposit account.

Respectfully submitted,

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ACCELERATED TEST METHOD AND SYSTEM
Application No. 10/713,154
Inventor: Yen-Fu LIU
Annotated Sheets

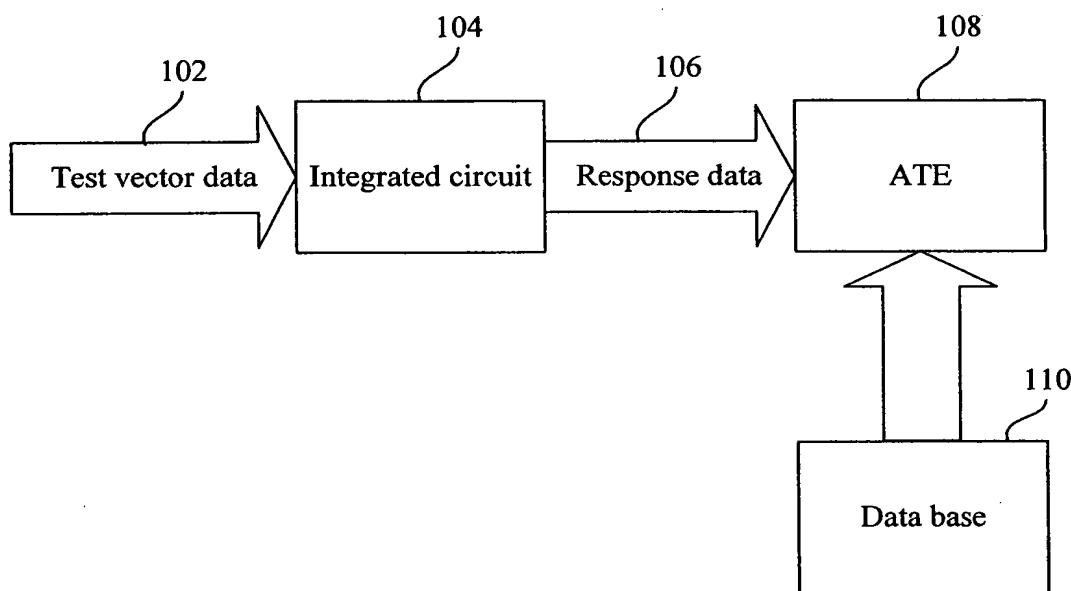


Fig. 1
(PRIOR ART)

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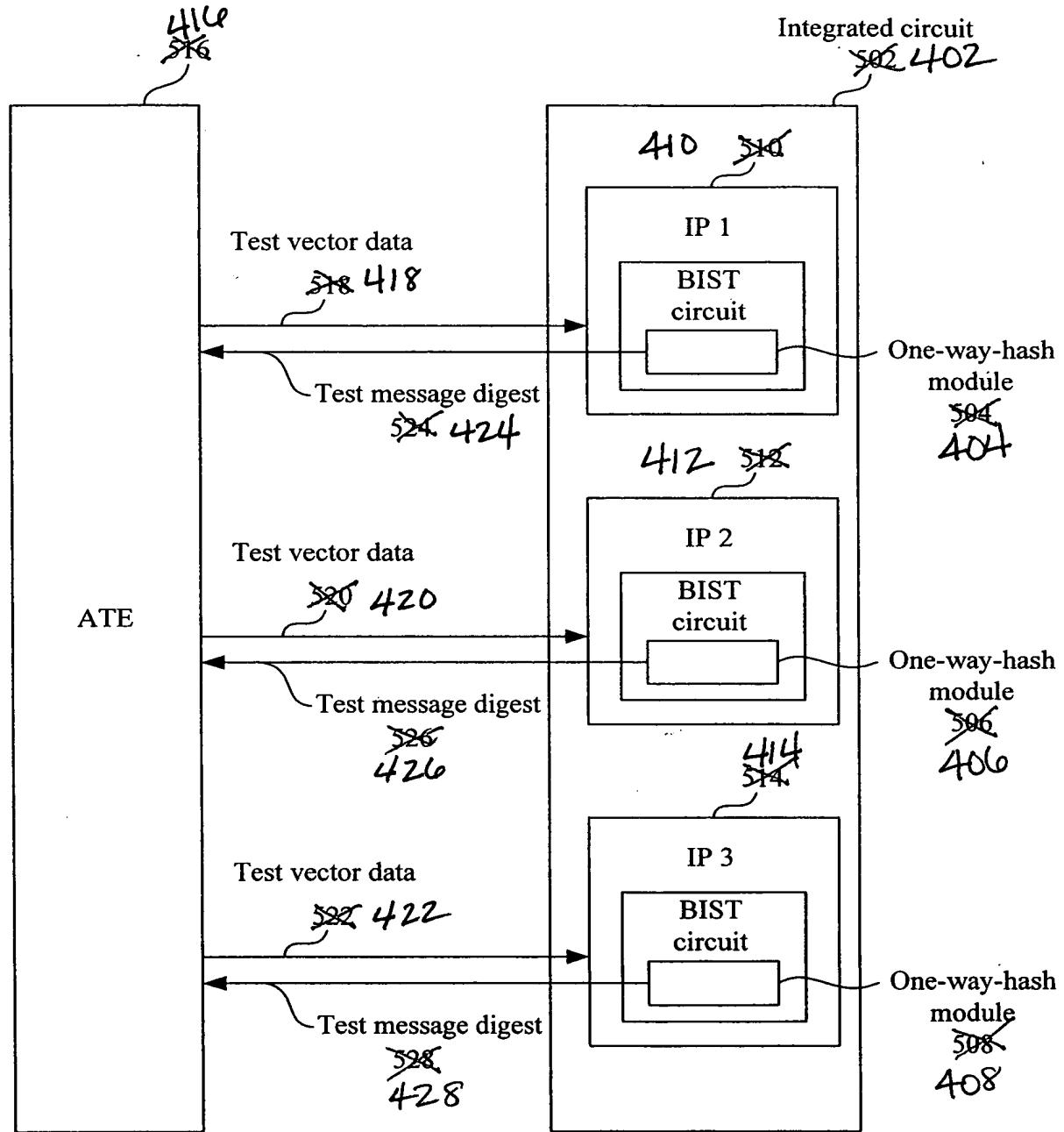


Fig. 4

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